

Notice of References Cited	Application/Control No. 09/908,930	Applicant(s)/Patent Under Reexamination LIOU ET AL.	
	Examiner Rachna Singh	Art Unit 2176	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,751,776	06-2004	Gong, Yihong	715/500.1
	B	US-2003/0028378	02-2003	AUGUST et al.	704/260
	C	US-5,956,026	09-1999	Ratakonda, Krishna	345/723
	D	US-2002/0097984	07-2002	Abecassis, Max	386/70
	E	US-6,665,870	12-2003	Finseth et al.	725/40
	F	US-5,991,594	11-1999	Froeber et al.	434/317
	G	US-5,995,095	11-1999	Ratakonda, Krishna	715/500.1
	H	US-6,633,741	10-2003	Posa et al.	434/317
	I	US-6,789,228	09-2004	Merril et al.	715/500.1
	J	US-6,675,350	01-2004	Abrams et al.	715/501.1
	K	US-6,690,725	02-2004	Abdeljaoud et al.	375/240.08
	L	US-6,697,523	02-2004	Divakaran et al.	382/173
	M	US-6,219,837	04-2001	Yeo et al.	725/38

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.